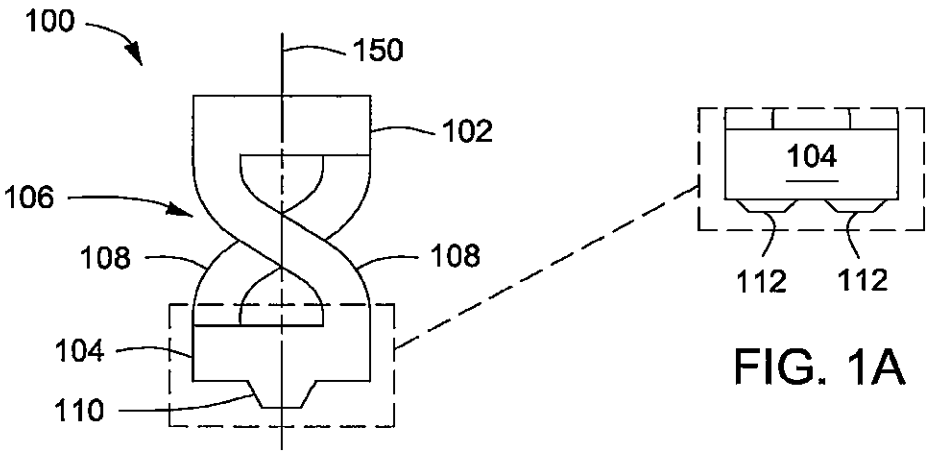


FIG. 1

FIG. 1A

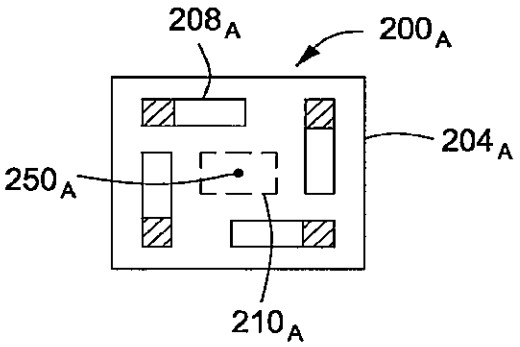


FIG. 2A

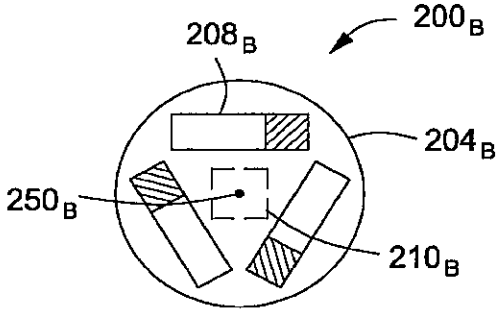


FIG. 2B

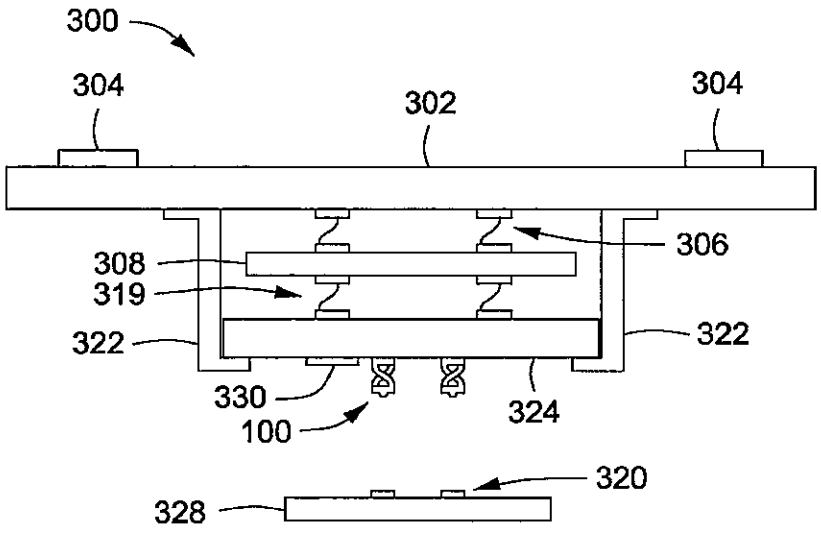


FIG. 3

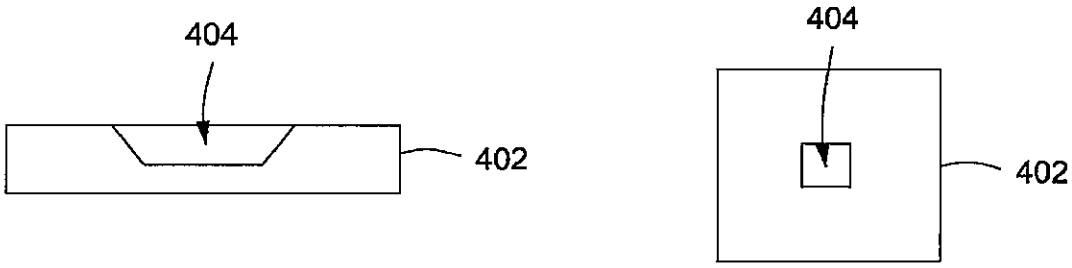


FIG. 4A

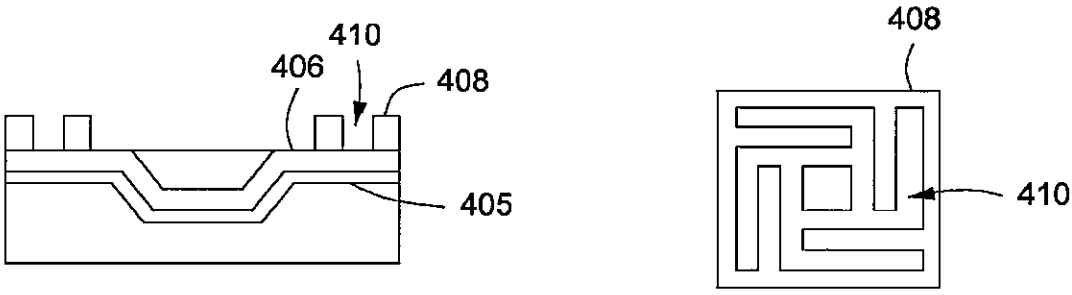


FIG. 4B

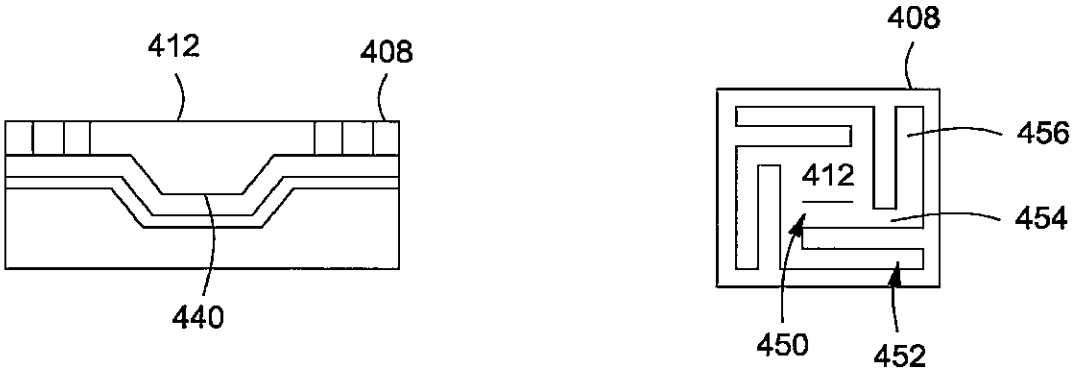


FIG. 4C

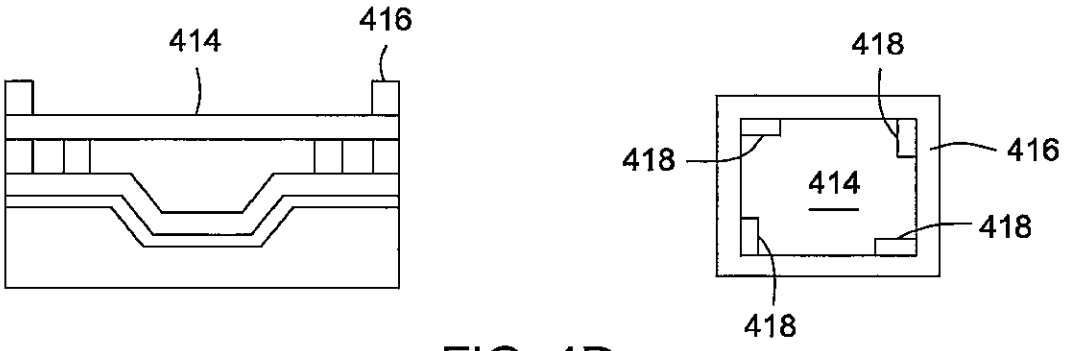


FIG. 4D

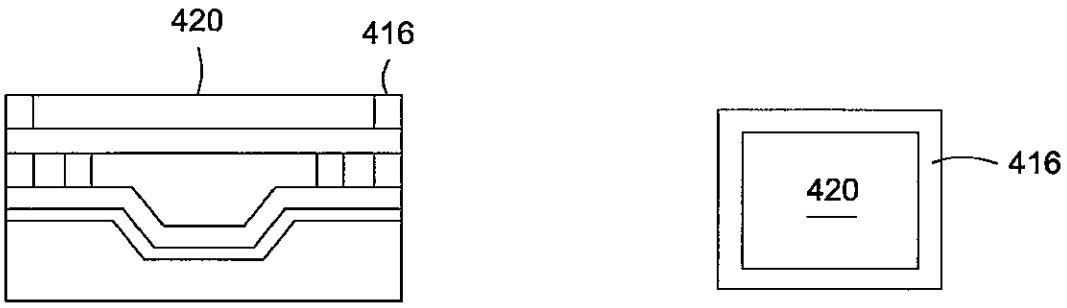


FIG. 4E

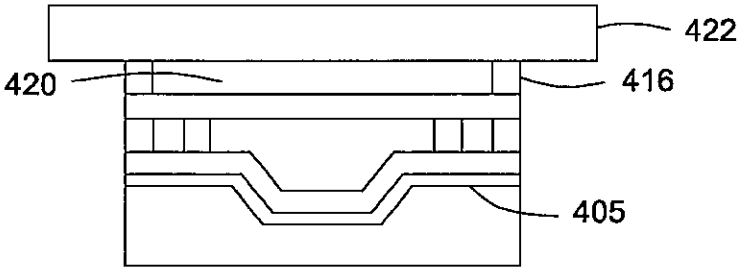


FIG. 4F

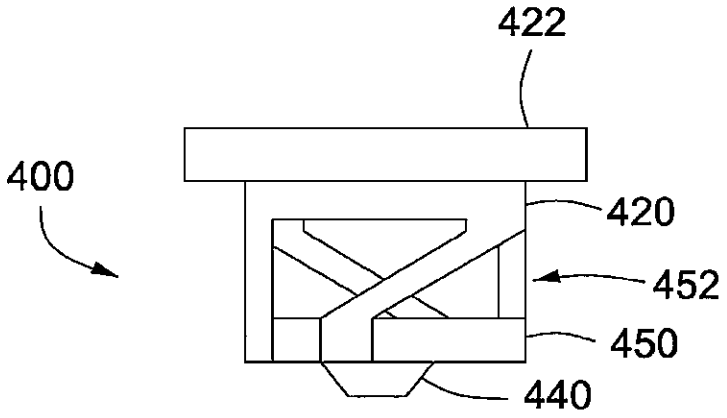


FIG. 4G

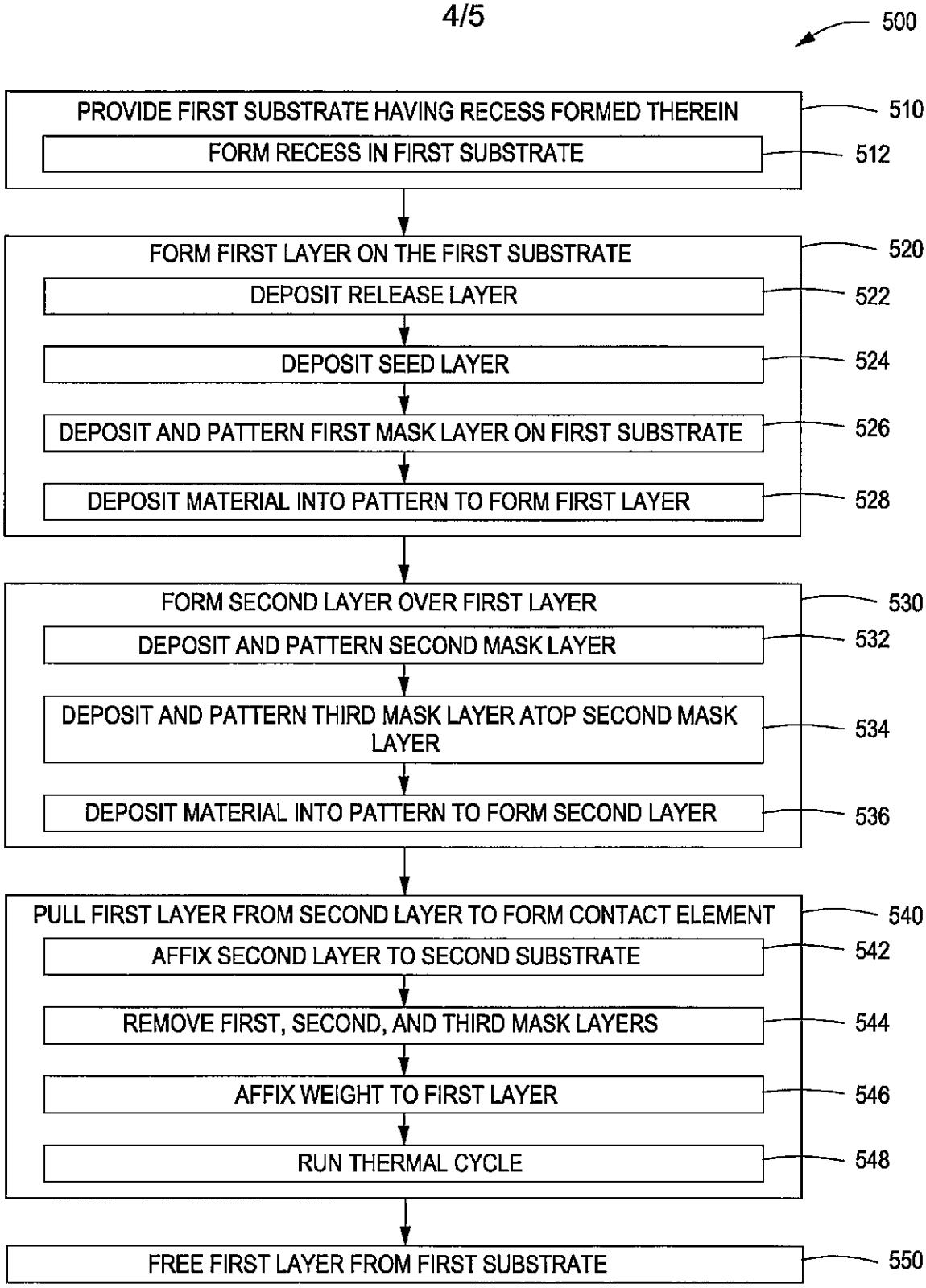

500
PROVIDE FIRST SUBSTRATE HAVING RECESS FORMED THEREIN
510
FORM RECESS IN FIRST SUBSTRATE
512
FORM FIRST LAYER ON THE FIRST SUBSTRATE
520
DEPOSIT RELEASE LAYER
522
DEPOSIT SEED LAYER
524
DEPOSIT AND PATTERN FIRST MASK LAYER ON FIRST SUBSTRATE
526
DEPOSIT MATERIAL INTO PATTERN TO FORM FIRST LAYER
528
FORM SECOND LAYER OVER FIRST LAYER
530
DEPOSIT AND PATTERN SECOND MASK LAYER
532
DEPOSIT AND PATTERN THIRD MASK LAYER ATOP SECOND MASK LAYER
534
DEPOSIT MATERIAL INTO PATTERN TO FORM SECOND LAYER
536
PULL FIRST LAYER FROM SECOND LAYER TO FORM CONTACT ELEMENT
540
AFFIX SECOND LAYER TO SECOND SUBSTRATE
542
REMOVE FIRST, SECOND, AND THIRD MASK LAYERS
544
AFFIX WEIGHT TO FIRST LAYER
546
RUN THERMAL CYCLE
548
FREE FIRST LAYER FROM FIRST SUBSTRATE
550

FIG. 5

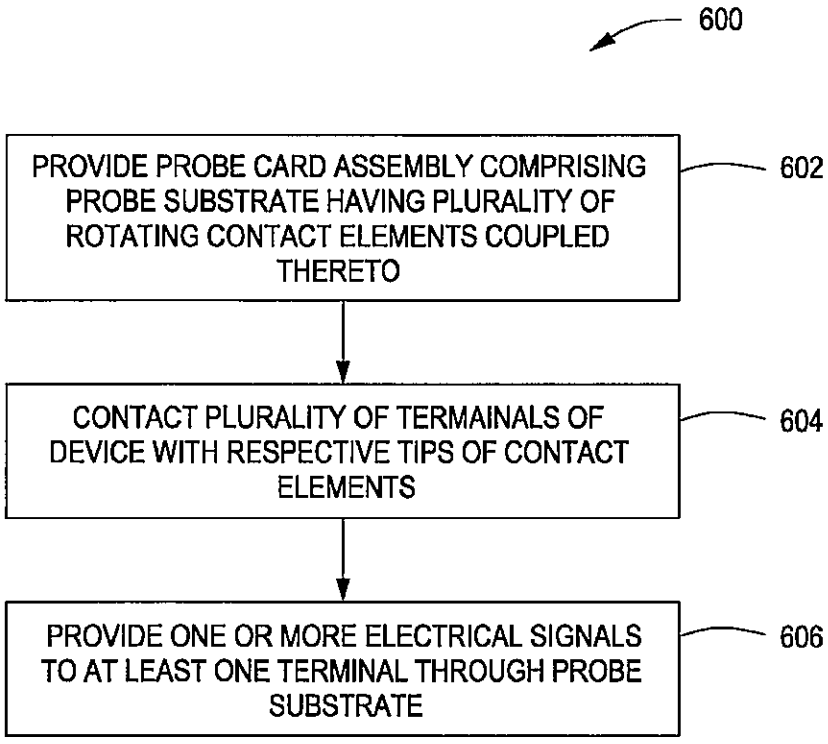

600
PROVIDE PROBE CARD ASSEMBLY COMPRISING PROBE SUBSTRATE HAVING PLURALITY OF ROTATING CONTACT ELEMENTS COUPLED THERETO
602
CONTACT PLURALITY OF TERMAINALS OF DEVICE WITH RESPECTIVE TIPS OF CONTACT ELEMENTS
604
PROVIDE ONE OR MORE ELECTRICAL SIGNALS TO AT LEAST ONE TERMINAL THROUGH PROBE SUBSTRATE
606

FIG. 6